

EAST Search History

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	1	(wafer adj3 numbers) and (wafer adj3 group) and (semiconductor adj3 chip) and (chip adj3 group) and (sub-groups) and (rectangular adj3 regions) and (lattice adj3 points) and (candidate adj3 measurement) and (fractional adj3 factorial)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/03/01 10:25
L2	1	(wafer adj3 numbers) and (wafer adj3 group) and (semiconductor) and (chip near3 group\$2) and (rectangular adj3 regions) and (lattice near4 point\$2) and (measurement) and (fractional near4 factorial)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/03/01 10:26
L3	1	(wafer) and (wafer near4 group) and (semiconductor) and (chip near3 group\$2) and (rectangular adj3 regions) and (lattice near4 point\$2) and (measurement) and (fractional near4 factorial)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/03/01 10:27
L4	1	(wafer) and (wafer near4 group) and (semiconductor) and (chip near3 group\$2) and (regions) and (lattice near4 point\$2) and (measurement) and (fractional near4 factorial)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/03/01 10:27